

<b>Notice of References Cited</b>	Application/Control No. 10/073,571		Applicant(s)/Patent Under Reexamination DAHNEKE ET AL.	
	Examiner Alan S. Chen		Art Unit 2182	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,167,538 A	12-2000	Neufeld et al.	714/47
*	B	US-6,825,941 B1	11-2004	Nguyen et al.	358/1.15
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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